Coating Thickness Measurement Instruments FMP10, FMP20, FMP30 and FMP40.

The Flexible Solution for Your Measurement Applications



State-of-the-Art Coating Thickness Measurement

The Fischer proven portable instruments with exchangeable probes allows for non-destructive and highly precise measurements of coatings. Whether for quality control in a manufacturing process or incoming inspection of random samples or complete batches, these user-friendly and flexible instruments will meet your requirements.

Select the appropriate instrument from the FMP family and combine it with one of our high-precision measurement probes.

Special features

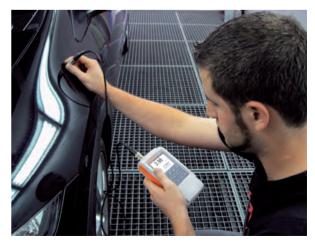
- Fast and non-destructive measurement on steel or iron (F) and non-ferrous metals (NF)
- Automatic probe and substrate recognition
- Large color display
- Supports measurements according to IMO PSPC, SSPC-PA2, QUALANOD and QUALICOAT
- USB interface, Bluetooth or COM interface as option
- Over 70 various high-precision probes for even the most sophisticated measurement applications



Quality monitoring on engine pistons immediately after the manufacturing process using the FTA3.3H probe



Measurements using the internal probe FAI 3.3-150



Paint coating thickness measurement using the dual probe FD13H

FMP10, FMP20, FMP30 and FMP40 Instrument Overview

Probes	DELTASCOPE®	DUALSCOPE®	ISOSCOPE®	Storable meas. applications	Statistics, evaluation	Measurement strategies
exchangeable	0.46	3.63	1.56	1	Display of the most significant statistical values (number of measurements, mean value, standard deviation, min, max, range)	Single reading acquisition Free-running display
	DELTASCOPE® FMP10	DUALSCOPE® FMP20	ISOSCOPE® FMP10			
	3 Bluetooth' DELTASCOPE® FMP30	3.25 S Bluetooth DUALSCOPE® FMP40	1.44 1.44	up to 100	Display of the most significant statistical values (number of measurements, mean value, standard deviation, min, max, range) and specific values Tolerance monitoring Graphical evaluation	Single reading acquisition Free-running display Area measurement Multiple measurements Automatic measurement Matrix mode IMO PSPC SSPC-PA2 QUALANOD QUALICOAT
Measurement method	Magnetic induction method (DIN EN ISO 2178, ASTM D7091)	Eddy current method and magnetic induction method (DIN EN ISO 2360 and 2178)	Eddy current method (DIN EN ISO 2360, ASTM D7091)			

DELTASCOPE® FMP10 and FMP30

For the measurement on ferrous substrates (F), e.g. paint, lacquer, powder coating, chrome, copper, zinc, as well as enamel or plastic coatings on steel and iron.

ISOSCOPE® FMP10 and FMP30

For the measurement of paint, powder coating, lacquer or plastic coatings on non-ferromagnetic metal substrates (NF) or anodic coatings on aluminum or electrically conducting coatings on non-conducting carrier materials.

DUALSCOPE® FMP20 and FMP40

Due to automatic substrate material recognition and the integration of both measurement methods, these universal instruments are capable of measuring coatings on steel and iron (F) and on non-ferromagnetic metals (NF). Duplex coatings (lacquer/zinc) on steel can be measured simultaneously with the values of the lacquer and zinc coatings displayed individually.



DUALSCOPE® FMP40 using the duplex probe FDX13H





DELTASCOPE® FMP10 using the probe FGAB1.3

The portable FMP10 and FMP20 represent precise measurement technology and are ideal for samples and control measurement. These user-friendly and sturdy instruments can be adapted to all requirements of coating thickness measurement using exchangeable measuring probes. The most significant statistical values are displayed and can be stored together with the calibration in the instrument, ensuring quick and reliable operation.

Features of the FMP10 and FMP20

Instrument features

- For magnetic induction and eddy current probes
- Automatic substrate and probe recognition
- Easy-to-use with intuitive menu
- Large contrast-rich color display
- Memory for up to 1,000 readings
- USB interface
- Instant measurement upon probe placement
- Audible signal with measurement acquisition
- Easy adaptation to the shape of the specimen through a zero-point correction (normalization)
- Easy to perform corrective calibration (verification of
- Sliding cover to protect keys against unintentional operation
- Various language settings
- Units of measurement can be switched between µm and mils

Measurement strategies and evaluation

- Single reading acquisition
- Measurements with the "free-running display" mode for continuous scanning of surfaces
- Statistical display of significant values such as mean value, standard deviation, min, max, range



DUALSCOPE® FMP20 using the probe FTD3.3



ISOSCOPE® FMP10 using the probe FTA3.3-Cu



Coating Thickness Measurement Instruments DELTASCOPE® FMP30, ISOSCOPE® FMP30, DUALSCOPE® FMP40

Additional features of the FMP30 and FMP40

Instrument features

- External key-triggered measurement acquisition, e.g. in hollow cylinders with small diameters
- Audible and visual warning when tolerance limits are exceeded
- Option Bluetooth or COM additional available to the default USB interface

Measurement application memory

- Application memory for up to 100 measuring applications incl. calibration (adjustment settings)
- Memory for up to 20,000 readings
- Allocation of readings into up to 4,000 blocks
- Date and time stamp for blocks
- Application linking mode: Common normalization/ calibration of measuring applications
- Validation of the corrective calibration by test measurements on standards

Measurement strategies and evaluation

- Stored specifications for measurements according to IMO PSPC, SSPC-PA2, QUALANOD and QUALICOAT
- Capability to enable matrix measurement mode for correlated multi-point measurements
- Averaging of measurement data: Only the mean value of several readings will be stored
- Measurement acquisition through area measurement:
 Single readings are captured until probe lift-off and averaged
- Outlier rejection settings for automatic elimination of erroneous measurements
- Free-running display with additional presentation of the reading as an analog bar between the tolerance limits
- Statistics display of the most significant values in the block and final results. Output of variance-analytical values
- Graphical measurement display as a histogram
- Capability of entering process tolerance limits and computation of the associated process capability indices c_p and c_{pk}



ISOSCOPE® FMP30 using probe FTA3.3H



DELTASCOPE® FMP30 using dual-tip probe V7FKB4



DUALSCOPE® FMP40 using probe FD13H

The FMP30 and FMP40 instruments feature additional more memory for numerous customer-specific measuring applications as well as extensive graphical and statistical evaluations. Tolerance limits can be entered into the calibratable measuring applications and the production process can be analyzed statistically.



DUALSCOPE® FMP40 using the probe FGAB1.3 and support stand V12 BASE – measuring parts with position accuracy

Versatile Probes Program and Ordering Information

Probe program

The extensive selection of FISCHER probes is as versatile as the measurement applications of our customers. A probe needs specific properties for each field of application for achieving best results with a high accuracy. Over 70 probes can be connected to the instrument family FMP10 to FMP40. Thus, you can solve even the most sophisticated measurement tasks.

Probe selection based on several criteria

- Material combination of coating and substrate
- Thickness of coating and substrate material
- Dimension of the measurement area
- Shape of the specimen
- Surface condition of the measurement area

We can help you choose the right probe for your speci-



Ordering information	Order no.
DELTASCOPE® FMP10	605-021
ISOSCOPE® FMP10	605-027
DUALSCOPE® FMP20	605-023
DELTASCOPE® FMP30	605-022
ISOSCOPE® FMP30	605-028
DUALSCOPE® FMP40	605-024

Standard content of instrument shipment

- Instrument
- Short form operator's manual, print version
- Support CD with evaluation and archiving software DataCenter, USB drivers and operator's manual
- Carrying strap FMP
- USB interface cable FMP/ PC
- Battery set FMP (Alkaline)
- Carrying case FMP only for FMP30 and FMP40 instruments

Optional accessories	Order no.
Carrying case FMP	604-148
Adapter E-probe/F-socket	604-214
AC adapter FMP30 and FMP40	604-290
Rechargeable battery set FMP (NiMH)	604-295
Charger AA/Mignon	604-335
Measurement stand V12 BASE	604-420
Measurement stand V12 MOT	604-374
(motor-driven)	
Bluetooth Module for wireless	604-480
data transfer	
COM Module FMP30/FMP40,	604-500
RS232 interface	
Interface connection set for COM Module	602-341
Protective cover for instrument	604-149

Service worldwide

FISCHER has established a tightly-linked global network of service partners with highly qualified staff. Offering fast help, repairs and the availability of leasing and rental units. FISCHER supports you in every respect concerning your instruments and their use.

Calibration and certification

Fischer Technology performs a full inspection and calibration of all instruments and probes prior to delivery to the customer. A broad assortment of calibration standards is available and a Certification certificate is issued with every instrument and calibration standard.



Application laboratories

More and more, demanding applications require highly qualified application advice. FISCHER addresses this need with its application laboratories located around the world (Germany, Switzerland, China, USA).



Measuring on a customer's specimen in a FISCHER application laboratory

User on-site training

We offer on-site training for your employees and take into account your individual requirements and requests.



User training for the DUALSCOPE® FMP100 on-site at the customer's

Seminars

Because we want you to receive maximum benefit from our products, FISCHER's experts are happy to share their application know-how. The seminars not only teach metrological basics but also hands-on experience in small groups to put the theory into practice.



A FISCHER seminar teaches metrological basics and practical knowledge in small groups

Helmut Fischer GmbH Institut für Elektronik und Messtechnik

71069 Sindelfingen, Germany Tel. +4970313030 mail@helmut-fischer.de





Fischer Instrumentation (GB) Ltd

Lymington, Hampshire SO41 8JD, England Tel. +44 15 90 68 41 00 mail@fischergb.co.uk



Fischer Technology, Inc.

Windsor, CT 06095, USA Tel. 1 (860) 683-0781 info@fischer-technology.com



Helmut Fischer S. de R.L. de C.V.

76230 Querétaro, QRO, Mexico Tel. +521 (442) 190-9988 hhuerta@fischer-technology.com

Helmut Fischer AG

CH-6331 Hünenberg, Switzerland





Tel. +41 41 785 08 00 switzerland@helmutfischer.com

Fischer Instrumentation Electronique

78180 Montigny le Bretonneux, France Tel. +33 1 30 58 00 58 france@helmutfischer.com

Helmut Fischer S.R.L.

20099 Sesto San Giovanni (Milano), Italy Tel. +39022552626 italy@helmutfischer.com

Fischer Instruments, S.A.

08018 Barcelona, Spain Tel. +34933097916 spain@helmutfischer.com

Helmut Fischer Meettechniek B.V.

5627 GB Eindhoven, The Netherlands Tel. +31 40 248 22 55 netherlands@helmutfischer.com

Fischer do Brasil

04561-001 São Paulo, Brazil Tel. +55 11 35 88 09 09 brasil@helmutfischer.com

Fischer Instruments K.K.

Saitama-ken 340-0012, Japan Tel. +81 489 29 34 55 japan@helmutfischer.com

Nantong Fischer Instrumentation Ltd

Shanghai 200333, P.R. China Tel. +862132513131 china@helmutfischer.com

Fischer Instrumentation (Far East) Ltd

Kwai Chung, N.T., Hong Kong Tel. +852 24 20 11 00 hongkong@helmutfischer.com

Fischer Measurement Technologies (India) Pvt. Ltd

Pune 411036, India Tel. +91 20 26 82 20 65 india@helmutfischer.com

Fischer Instrumentation (S) Pte Ltd

Singapore 658065, Singapore Tel. +65 62 76 67 76 singapore@helmutfischer.com

Helmut Fischer Korea Co., Ltd Seoul-City, Republic of Korea

Tel. +82 24 15 23 81 korea@helmutfischer.com



www.helmut-fischer.com

10/12